

**Search Notes****Application/Control No.**

10/722,178

**Examiner**

Hai L. Nguyen

**Applicant(s)/Patent under Reexamination**

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**Art Unit**

2816

**SEARCHED**

Class	Subclass	Date	Examiner
331	16,17	4/18/2005	HLN
327	311,312	—	—
327	551-559	—	—
Update	Search	9/30/2005	HLN
Update	Search	1/10/2006	HLN
Update	Search	7/3/2006	HLN
Update	Search	8/18/2006	HLN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

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**INTERFERENCE SEARCHED**

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